

# Si/SiC Hybrid Module – EliteSiC, I-Type NPC 1000 V, 400 A IGBT, 1200 V, 100 A SiC Diode, Q2 Package

## NXH400N100H4Q2F2PG, NXH400N100H4Q2F2SG, NXH400N100H4Q2F2SG-R

This high-density, integrated power module combines high-performance IGBTs with rugged anti-parallel diodes.

### Features

- Extremely Efficient Trench with Field Stop Technology
- Low Switching Loss Reduces System Power Dissipation
- Module Design Offers High Power Density
- Low Inductive Layout
- Low Package Height
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

### Typical Applications

- Solar Inverters
- Uninterruptable Power Supplies Systems

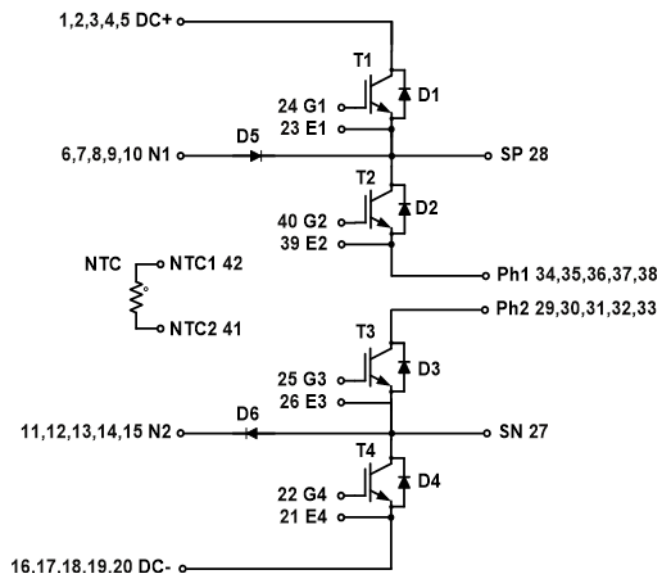
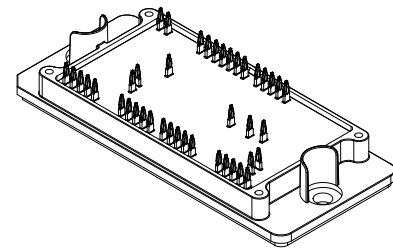
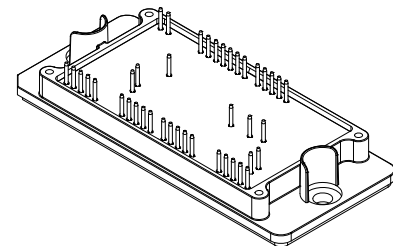


Figure 1. NXH400N100H4Q2F2PG/SG/SG-R Schematic Diagram

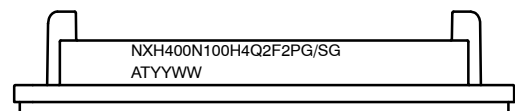


Q2PACK INPC PRESS FIT PINS  
PIM42, 93x47 (PRESSFIT)  
CASE 180BH



Q2PACK INPC SOLDER PINS  
PIM44, 93x47 (SOLDER PIN)  
CASE 180BS

### MARKING DIAGRAM



NXH400N100H4Q2F2PG/SG = Specific Device Code  
G = Pb-Free Package  
AT = Assembly & Test Site Code  
YYWW = Year and Work Week Code

### PIN CONNECTIONS

See details pin connections on page 2 of this data sheet.

### ORDERING INFORMATION

See detailed ordering and shipping information on page 6 of this data sheet.

PIN CONNECTIONS

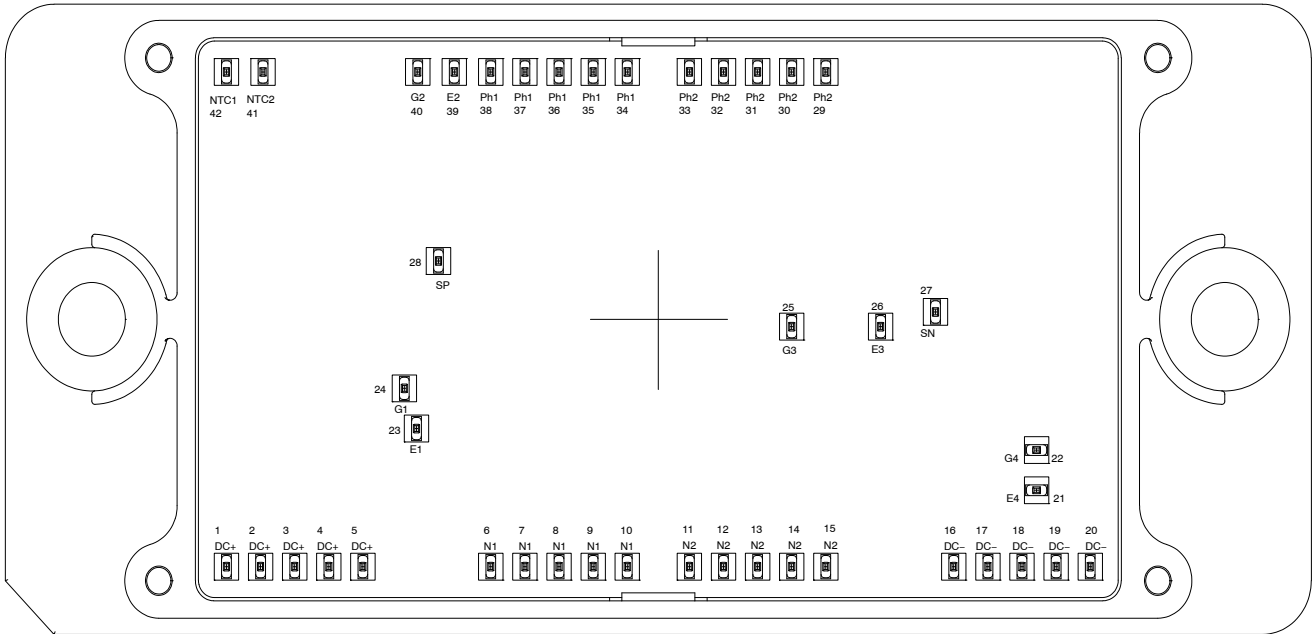


Figure 2. Pin Connections

**ABSOLUTE MAXIMUM RATINGS** ( $T_J = 25^\circ\text{C}$  unless otherwise noted)

Rating	Symbol	Value	Unit
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**OUTER IGBT (T1, T4)**

Collector-Emitter Voltage	$V_{CES}$	1000	V
Gate-Emitter Voltage Positive Transient Gate-Emitter Voltage ( $T_{pulse} = 5 \mu\text{s}$ , $D < 0.10$ )	$V_{GE}$	$\pm 20$ 30	V
Continuous Collector Current @ $T_C = 80^\circ\text{C}$	$I_C$	409	A
Pulsed Peak Collector Current @ $T_C = 80^\circ\text{C}$ ( $T_J = 150^\circ\text{C}$ )	$I_{C(Pulse)}$	1227	A
Maximum Power Dissipation ( $T_J = 150^\circ\text{C}$ )	$P_{tot}$	959	W
Minimum Operating Junction Temperature	$T_{JMIN}$	-40	$^\circ\text{C}$
Maximum Operating Junction Temperature	$T_{JMAX}$	175	$^\circ\text{C}$

**INNER IGBT (T2, T3)**

Collector-Emitter Voltage	$V_{CES}$	1000	V
Gate-Emitter Voltage Positive Transient Gate-Emitter Voltage ( $T_{pulse} = 5 \mu\text{s}$ , $D < 0.10$ )	$V_{GE}$	$\pm 20$ 30	V
Continuous Collector Current @ $T_C = 80^\circ\text{C}$	$I_C$	360	A
Pulsed Peak Collector Current @ $T_C = 80^\circ\text{C}$ ( $T_J = 150^\circ\text{C}$ )	$I_{C(Pulse)}$	1080	A
Maximum Power Dissipation ( $T_J = 175^\circ\text{C}$ )	$P_{tot}$	805	W
Minimum Operating Junction Temperature	$T_{JMIN}$	-40	$^\circ\text{C}$
Maximum Operating Junction Temperature	$T_{JMAX}$	175	$^\circ\text{C}$

**IGBT INVERSE DIODE (D1, D2, D3, D4)**

Peak Repetitive Reverse Voltage	$V_{RRM}$	1000	V
Continuous Forward Current @ $T_C = 80^\circ\text{C}$	$I_F$	192	A
Repetitive Peak Forward Current ( $T_J = 175^\circ\text{C}$ )	$I_{FRM}$	576	A

# NXH400N100H4Q2F2PG, NXH400N100H4Q2F2SG, NXH400N100H4Q2F2SG-R

## ABSOLUTE MAXIMUM RATINGS ( $T_J = 25^\circ\text{C}$ unless otherwise noted) (continued)

Rating	Symbol	Value	Unit
<b>IGBT INVERSE DIODE (D1, D2, D3, D4)</b>			
Maximum Power Dissipation ( $T_J = 175^\circ\text{C}$ )	$P_{\text{tot}}$	482	W
Minimum Operating Junction Temperature	$T_{\text{JMIN}}$	-40	$^\circ\text{C}$
Maximum Operating Junction Temperature	$T_{\text{JMAX}}$	175	$^\circ\text{C}$

## NEUTRAL POINT DIODE (D5, D6)

Peak Repetitive Reverse Voltage	$V_{\text{RRM}}$	1200	V
Continuous Forward Current @ $T_C = 80^\circ\text{C}$	$I_F$	140	A
Repetitive Peak Forward Current ( $T_J = 175^\circ\text{C}$ )	$I_{\text{FRM}}$	420	A
Maximum Power Dissipation ( $T_J = 175^\circ\text{C}$ )	$P_{\text{tot}}$	401	W
Minimum Operating Junction Temperature	$T_{\text{JMIN}}$	-40	$^\circ\text{C}$
Maximum Operating Junction Temperature	$T_{\text{JMAX}}$	175	$^\circ\text{C}$

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Refer to [ELECTRICAL CHARACTERISTICS](#) and/or APPLICATION INFORMATION for Safe Operating parameters.

## THERMAL AND INSULATION PROPERTIES ( $T_J = 25^\circ\text{C}$ unless otherwise noted)

Rating	Symbol	Value	Unit
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### THERMAL PROPERTIES

Operating Temperature under Switching Condition	$T_{\text{VJOP}}$	-40 to 150	$^\circ\text{C}$
Storage Temperature Range	$T_{\text{stg}}$	-40 to 125	$^\circ\text{C}$

### INSULATION PROPERTIES

Isolation Test Voltage, $t = 2$ s, 50 Hz (Note 3)	$V_{\text{is}}$	4000	$V_{\text{RMS}}$
Creepage Distance		12.7	mm
Comparative Tracking Index	CTI	>600	

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

2. Refer to [ELECTRICAL CHARACTERISTICS](#) and/or APPLICATION INFORMATION for Safe Operating parameters.
3. 4000  $V_{\text{ACRMS}}$  for 1 second duration is equivalent to 3333  $V_{\text{ACRMS}}$  for 1 minute duration.

# NXH400N100H4Q2F2PG, NXH400N100H4Q2F2SG, NXH400N100H4Q2F2SG-R

## ELECTRICAL CHARACTERISTICS (T<sub>J</sub> = 25°C unless otherwise specified)

Characteristic	Test Conditions	Symbol	Min	Typ	Max	Unit
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### OUTER IGBT (T1, T4) CHARACTERISTICS

Collector-Emitter Cutoff Current	V <sub>GE</sub> = 0 V, V <sub>CE</sub> = 1000 V	I <sub>CES</sub>	–	–	500	μA
Collector-Emitter Saturation Voltage	V <sub>GE</sub> = 15 V, I <sub>C</sub> = 400 A, T <sub>J</sub> = 25°C	V <sub>CE(sat)</sub>	–	1.77	2.3	V
	V <sub>GE</sub> = 15 V, I <sub>C</sub> = 400 A, T <sub>J</sub> = 150°C		–	2.11	–	
Gate-Emitter Threshold Voltage	V <sub>GE</sub> = V <sub>CE</sub> , I <sub>C</sub> = 400 mA	V <sub>GE(TH)</sub>	4.1	5.1	6.1	V
Gate Leakage Current	V <sub>GE</sub> = ±20 V, V <sub>CE</sub> = 0 V	I <sub>GES</sub>	–	–	±2000	nA
Internal Gate Resistor		R <sub>G</sub>	–	1.44	–	Ω
Turn-on Delay Time	T <sub>J</sub> = 25°C V <sub>CE</sub> = 600 V, I <sub>C</sub> = 150 A V <sub>GE</sub> = -8 V, 15 V, R <sub>Gon</sub> = 6 Ω, R <sub>Goff</sub> = 11 Ω	t <sub>d(on)</sub>	–	151	–	ns
Rise Time		t <sub>r</sub>	–	35	–	
Turn-off Delay Time		t <sub>d(off)</sub>	–	551	–	
Fall Time		t <sub>f</sub>	–	68	–	μJ
Turn-on Switching Loss per Pulse		E <sub>on</sub>	–	3270	–	
Turn-off Switching Loss per Pulse		E <sub>off</sub>	–	5100	–	
Turn-on Delay Time	T <sub>J</sub> = 125°C V <sub>CE</sub> = 600 V, I <sub>C</sub> = 150 A V <sub>GE</sub> = -8 V, 15 V, R <sub>Gon</sub> = 6 Ω, R <sub>Goff</sub> = 11 Ω	t <sub>d(on)</sub>	–	146	–	ns
Rise Time		t <sub>r</sub>	–	40	–	
Turn-off Delay Time		t <sub>d(off)</sub>	–	626	–	
Fall Time		t <sub>f</sub>	–	88	–	μJ
Turn-on Switching Loss per Pulse		E <sub>on</sub>	–	4165	–	
Turn-off Switching Loss per Pulse		E <sub>off</sub>	–	8420	–	
Input Capacitance	V <sub>CE</sub> = 20 V, V <sub>GE</sub> = 0 V, f = 1 MHz	C <sub>ies</sub>	–	26093	–	pF
Output Capacitance		C <sub>oes</sub>	–	1012	–	
Reverse Transfer Capacitance		C <sub>res</sub>	–	104	–	
Total Gate Charge	V <sub>CE</sub> = 600 V, I <sub>C</sub> = 300 A, V <sub>GE</sub> = -15 V~15 V	Q <sub>g</sub>	–	1304	–	nC
Thermal Resistance – Chip-to-Heatsink	Thermal grease, Thickness = 2.1 Mil ±2% λ = 2.9 W/mK	R <sub>thJH</sub>	–	0.181	–	K/W
Thermal Resistance – Chip-to-Case		R <sub>thJC</sub>	–	0.073	–	K/W

### NEUTRAL POINT DIODE (D5, D6) CHARACTERISTICS

Diode Forward Voltage	I <sub>F</sub> = 100 A, T <sub>J</sub> = 25°C	V <sub>F</sub>	–	1.50	1.85	V
	I <sub>F</sub> = 100 A, T <sub>J</sub> = 150°C		–	2.07	–	
Reverse Recovery Time	T <sub>J</sub> = 25°C V <sub>CE</sub> = 600 V, I <sub>C</sub> = 150 A V <sub>GE</sub> = -8 V, 15 V, R <sub>G</sub> = 6 Ω	t <sub>rr</sub>	–	19	–	ns
Reverse Recovery Charge		Q <sub>rr</sub>	–	229	–	nC
Peak Reverse Recovery Current		I <sub>RRM</sub>	–	19	–	A
Peak Rate of Fall of Recovery Current		di/dt	–	6053	–	A/μs
Reverse Recovery Energy		E <sub>rr</sub>	–	164	–	μJ
Reverse Recovery Time		T <sub>J</sub> = 125°C V <sub>CE</sub> = 600 V, I <sub>C</sub> = 150 A V <sub>GE</sub> = -8 V, 15 V, R <sub>G</sub> = 6 Ω	t <sub>rr</sub>	–	34	–
Reverse Recovery Charge	Q <sub>rr</sub>		–	359	–	nC
Peak Reverse Recovery Current	I <sub>RRM</sub>		–	17	–	A
Peak Rate of Fall of Recovery Current	di/dt		–	4621	–	A/μs
Reverse Recovery Energy	E <sub>rr</sub>		–	211	–	μJ
Thermal Resistance – Chip-to-Heatsink	Thermal grease, Thickness = 2.1 Mil ±2% λ = 2.9 W/mK		R <sub>thJH</sub>	–	0.364	–
Thermal Resistance – Chip-to-Case		R <sub>thJC</sub>	–	0.237	–	K/W

# NXH400N100H4Q2F2PG, NXH400N100H4Q2F2SG, NXH400N100H4Q2F2SG-R

## ELECTRICAL CHARACTERISTICS (T<sub>J</sub> = 25°C unless otherwise specified) (continued)

Characteristic	Test Conditions	Symbol	Min	Typ	Max	Unit
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### INNER IGBT (T2, T3) CHARACTERISTICS

Collector-Emitter Cutoff Current	V <sub>GE</sub> = 0 V, V <sub>CE</sub> = 1000 V	I <sub>CES</sub>	–	–	500	μA
Collector-Emitter Saturation Voltage	V <sub>GE</sub> = 15 V, I <sub>C</sub> = 400 A, T <sub>J</sub> = 25°C	V <sub>CE(sat)</sub>	–	1.77	2.3	V
	V <sub>GE</sub> = 15 V, I <sub>C</sub> = 400 A, T <sub>J</sub> = 150°C		–	2.11	–	
Gate-Emitter Threshold Voltage	V <sub>GE</sub> = V <sub>CE</sub> , I <sub>C</sub> = 400 mA	V <sub>GE(TH)</sub>	4.1	5.1	6.1	V
Gate Leakage Current	V <sub>GE</sub> = ±20 V, V <sub>CE</sub> = 0 V	I <sub>GES</sub>	–	–	±2000	nA
Internal Gate Resistor		R <sub>G</sub>	–	1.44	–	Ω
Turn-on Delay Time	T <sub>J</sub> = 25°C V <sub>CE</sub> = 600 V, I <sub>C</sub> = 150 A V <sub>GE</sub> = -8 V, 15 V, R <sub>Gon</sub> = 6 Ω, R <sub>Goff</sub> = 23 Ω	t <sub>d(on)</sub>	–	149	–	ns
Rise Time		t <sub>r</sub>	–	37	–	
Turn-off Delay Time		t <sub>d(off)</sub>	–	882	–	
Fall Time		t <sub>f</sub>	–	35	–	μJ
Turn-on Switching Loss per Pulse		E <sub>on</sub>	–	4970	–	
Turn-off Switching Loss per Pulse		E <sub>off</sub>	–	6010	–	
Turn-on Delay Time	T <sub>J</sub> = 125°C V <sub>CE</sub> = 600 V, I <sub>C</sub> = 150 A V <sub>GE</sub> = -8 V, 15 V, R <sub>Gon</sub> = 6 Ω, R <sub>Goff</sub> = 23 Ω	t <sub>d(on)</sub>	–	146	–	ns
Rise Time		t <sub>r</sub>	–	42	–	
Turn-off Delay Time		t <sub>d(off)</sub>	–	977	–	
Fall Time		t <sub>f</sub>	–	12	–	μJ
Turn-on Switching Loss per Pulse		E <sub>on</sub>	–	7790	–	
Turn-off Switching Loss per Pulse		E <sub>off</sub>	–	8530	–	
Input Capacitance	V <sub>CE</sub> = 20 V, V <sub>GE</sub> = 0 V, f = 1 MHz	C <sub>ies</sub>	–	26093	–	pF
Output Capacitance		C <sub>oes</sub>	–	1012	–	
Reverse Transfer Capacitance		C <sub>res</sub>	–	104	–	
Total Gate Charge	V <sub>CE</sub> = 600 V, I <sub>C</sub> = 300 A, V <sub>GE</sub> = 15 V	Q <sub>g</sub>	–	1304	–	nC
Thermal Resistance – Chip-to-Heatsink	Thermal grease, Thickness = 2.1 Mil ±2% λ = 2.9 W/mK	R <sub>thJH</sub>	–	0.207	–	K/W
Thermal Resistance – Chip-to-Case		R <sub>thJC</sub>	–	0.087	–	K/W

### IGBT INVERSE DIODE (D1, D2, D3, D4) CHARACTERISTICS

Diode Forward Voltage	I <sub>F</sub> = 150 A, T <sub>J</sub> = 25°C	V <sub>F</sub>	–	2.0	2.6	V
	I <sub>F</sub> = 150 A, T <sub>J</sub> = 150°C		–	1.77	–	
Reverse Recovery Time	T <sub>J</sub> = 25°C V <sub>CE</sub> = 600 V, I <sub>C</sub> = 150 A V <sub>GE</sub> = -8 V, 15 V, R <sub>G</sub> = 6 Ω	t <sub>rr</sub>	–	105	–	ns
Reverse Recovery Charge		Q <sub>rr</sub>	–	4179	–	nC
Peak Reverse Recovery Current		I <sub>RRM</sub>	–	97	–	A
Peak Rate of Fall of Recovery Current		di/dt	–	4571	–	A/μs
Reverse Recovery Energy		E <sub>rr</sub>	–	950	–	μJ
Reverse Recovery Time		T <sub>J</sub> = 125°C V <sub>CE</sub> = 600 V, I <sub>C</sub> = 150 A V <sub>GE</sub> = -8 V, 15 V, R <sub>G</sub> = 6 Ω	t <sub>rr</sub>	–	179	–
Reverse Recovery Charge	Q <sub>rr</sub>		–	11900	–	nC
Peak Reverse Recovery Current	I <sub>RRM</sub>		–	132	–	A
Peak Rate of Fall of Recovery Current	di/dt		–	4167	–	A/μs
Reverse Recovery Energy	E <sub>rr</sub>		–	3750	–	μJ
Thermal Resistance – Chip-to-Heatsink	Thermal grease, Thickness = 2.1 Mil ±2% λ = 2.9 W/mK		R <sub>thJH</sub>	–	0.316	–
Thermal Resistance – Chip-to-Case		R <sub>thJC</sub>	–	0.197	–	K/W

# NXH400N100H4Q2F2PG, NXH400N100H4Q2F2SG, NXH400N100H4Q2F2SG-R

## ELECTRICAL CHARACTERISTICS ( $T_J = 25^\circ\text{C}$ unless otherwise specified) (continued)

Characteristic	Test Conditions	Symbol	Min	Typ	Max	Unit
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### THERMISTOR CHARACTERISTICS

Nominal Resistance	$T = 25^\circ\text{C}$	$R_{25}$	–	22	–	$\text{k}\Omega$
Nominal Resistance	$T = 100^\circ\text{C}$	$R_{100}$	–	1486	–	$\Omega$
Deviation of $R_{25}$		$\Delta R/R$	-5	–	5	%
Power Dissipation		$P_D$	–	200	–	mW
Power Dissipation Constant			–	2	–	mW/K
B-value	B (25/50), tolerance $\pm 3\%$		–	3950	–	K
B-value	B (25/100), tolerance $\pm 3\%$		–	3998	–	K

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

### ORDERING INFORMATION

Part Number	Marking	Package	Shipping
NXH400N100H4Q2F2PG PRESS FIT PINS	NXH400N100H4Q2F2PG	PIM42, 93x47 (PRESSFIT) (Pb-Free/Halide-Free)	12 Units / Blister Tray
NXH400N100H4Q2F2SG, NXH400N100H4Q2F2SG-R SOLDER PINS	NXH400N100H4Q2F2SG, NXH400N100H4Q2F2SG-R	PIM44, 93x47 (SOLDER PIN) (Pb-Free/Halide-Free)	12 Units / Blister Tray

TYPICAL CHARACTERISTICS – IGBT, INVERSE DIODE AND NEUTRAL POINT DIODE

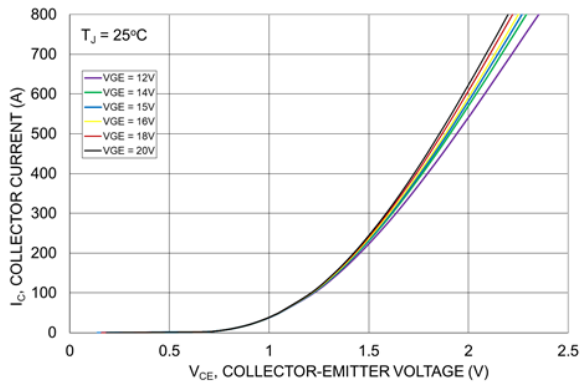


Figure 3. Typical Output Characteristics – Inner IGBT

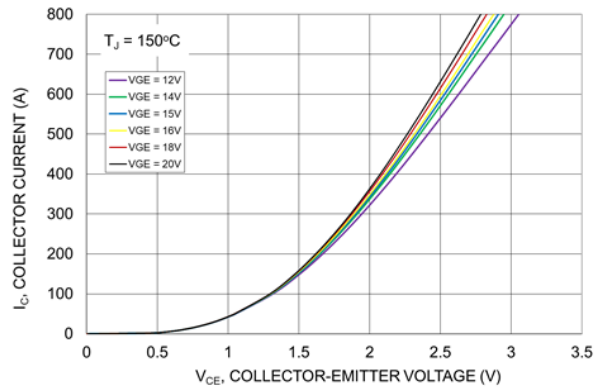


Figure 4. Typical Output Characteristics – Inner IGBT

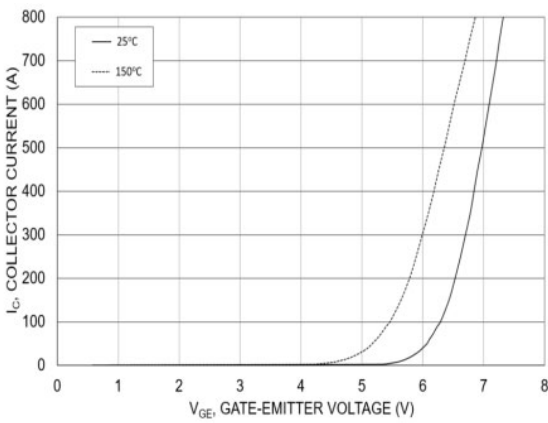


Figure 5. Transfer Characteristics – Inner IGBT

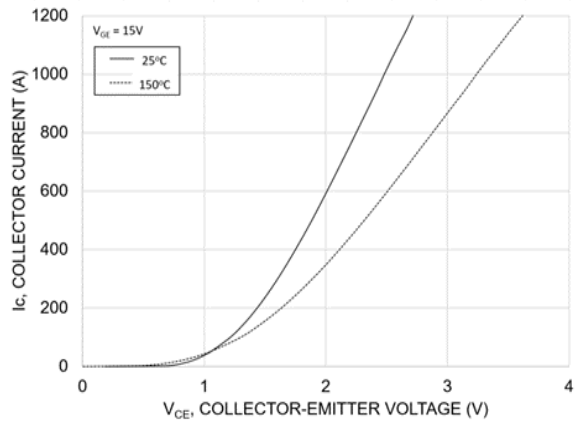


Figure 6. Saturation Voltage Characteristic

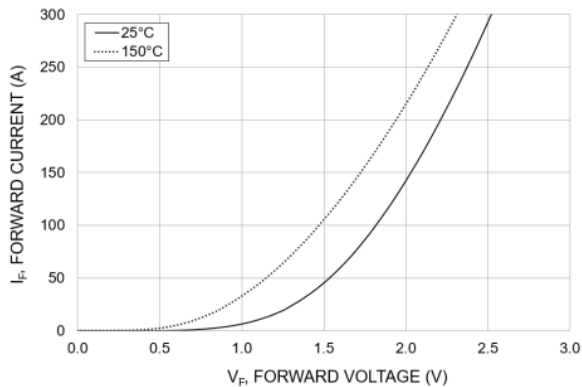


Figure 7. Inverse Diode Forward Characteristics

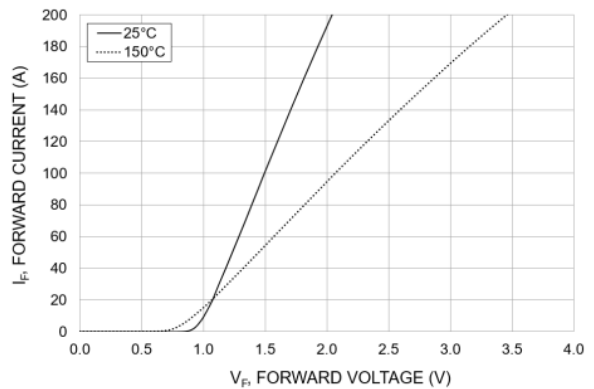


Figure 8. Buck Diode Forward Characteristics

TYPICAL CHARACTERISTICS – OUTER IGBT

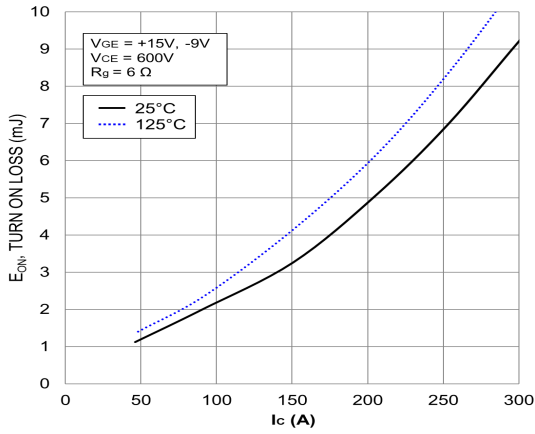


Figure 9. Typical Turn ON Loss vs. IC

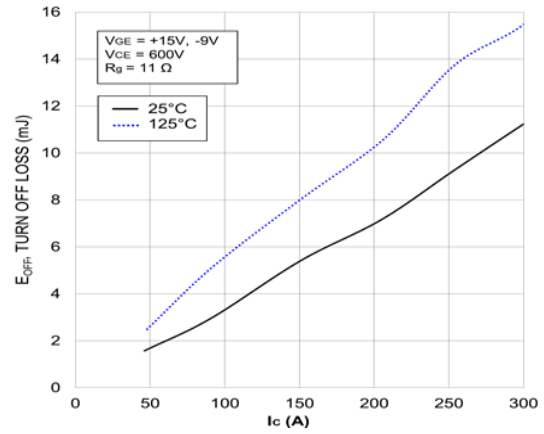


Figure 10. Typical Turn OFF Loss vs. IC

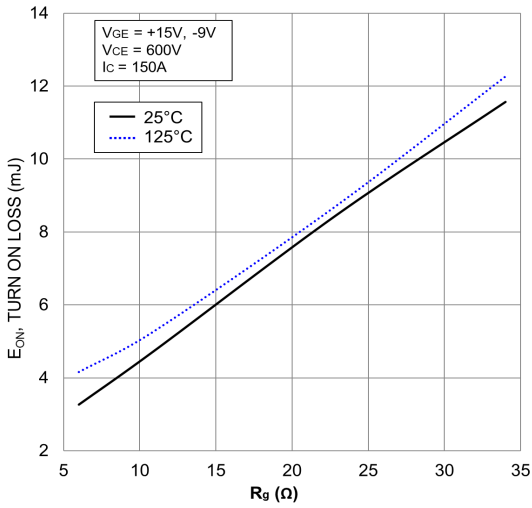


Figure 11. Typical Turn ON Loss vs.  $R_g$

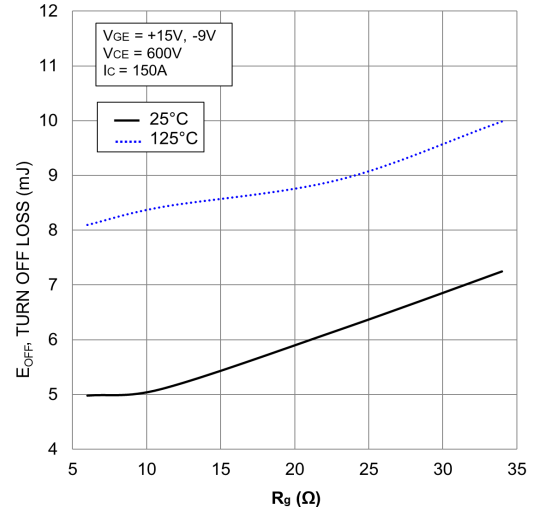


Figure 12. Typical Turn OFF Loss vs.  $R_g$

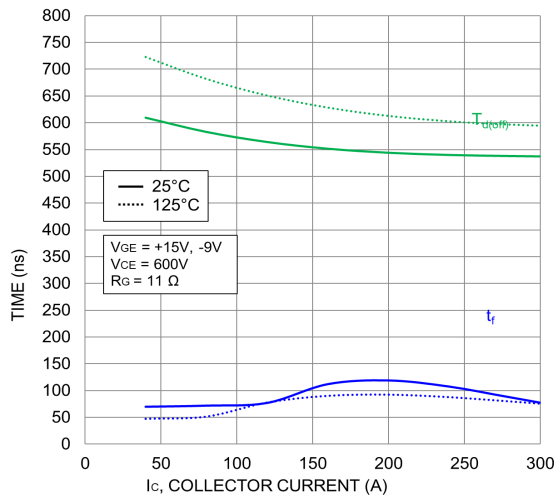


Figure 13. Typical Turn-Off Switching Time vs. IC

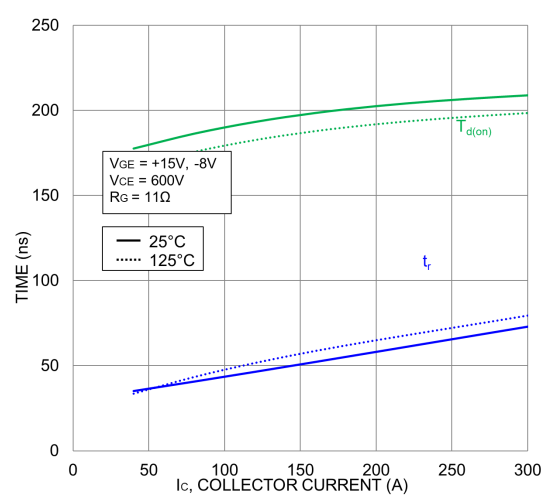


Figure 14. Typical Turn-On Switching Time vs. IC



TYPICAL CHARACTERISTICS – OUTER IGBT (CONTINUED)

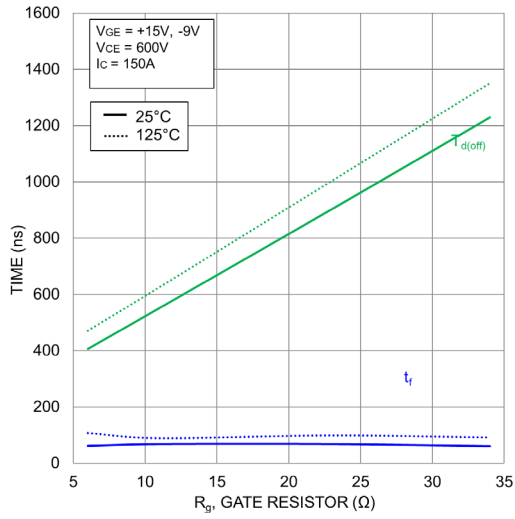


Figure 15. Typical Turn-Off Switching Time vs.  $R_g$

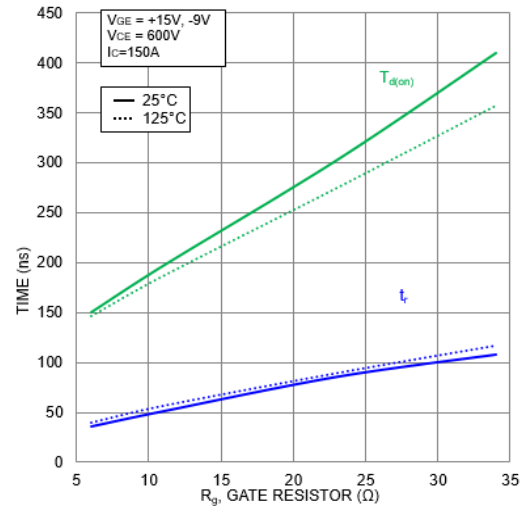


Figure 16. Typical Turn-On Switching Time vs.  $R_g$

TYPICAL CHARACTERISTICS – INNER IGBT

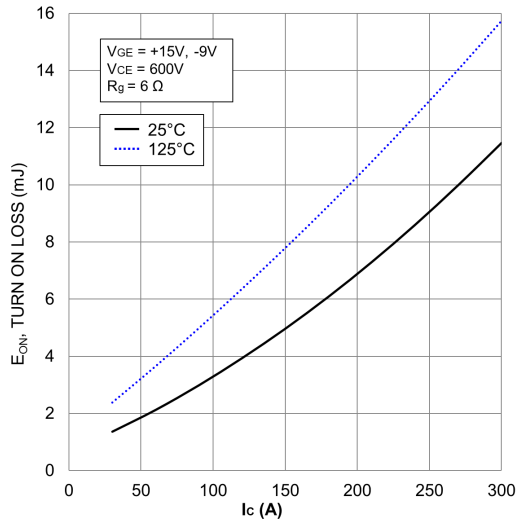


Figure 17. Typical Turn On Switching Time vs.  $I_C$

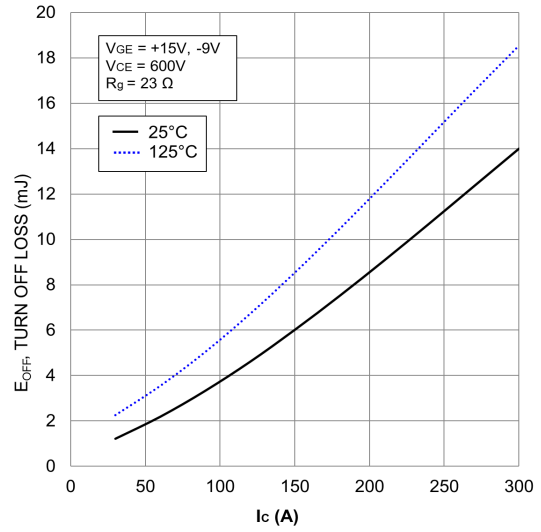


Figure 18. Typical Turn Off Switching Time vs.  $I_C$

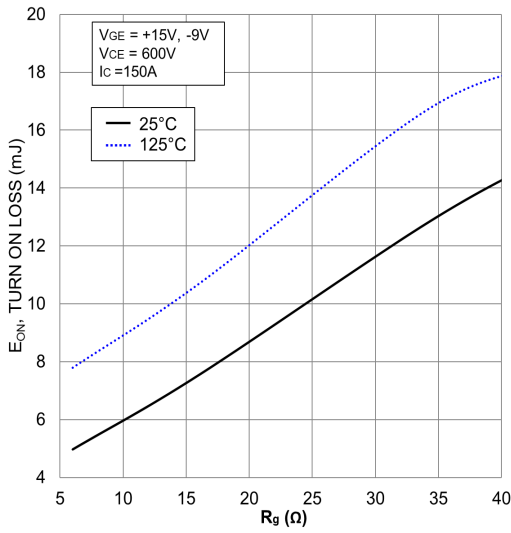


Figure 19. Typical Turn On Switching Time vs.  $R_G$

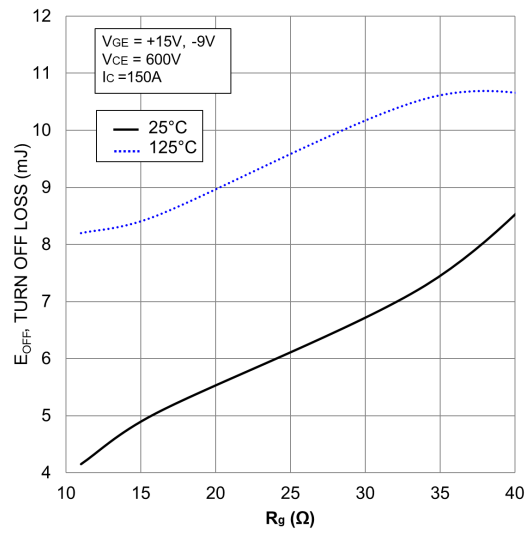


Figure 20. Typical Turn Off Switching Time vs.  $R_G$

TYPICAL CHARACTERISTICS – INNER IGBT (CONTINUED)

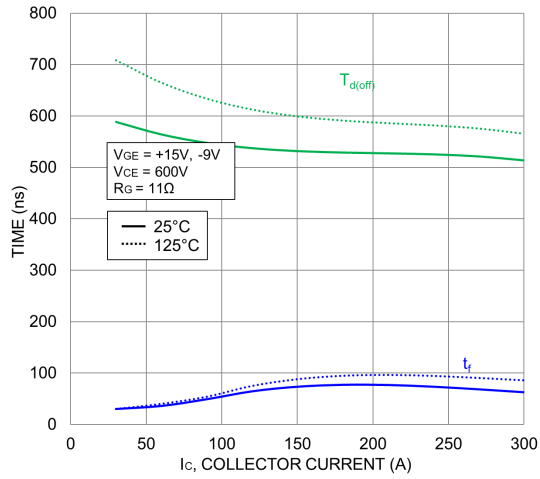


Figure 23. Typical Turn-Off Switching Time vs.  $I_c$

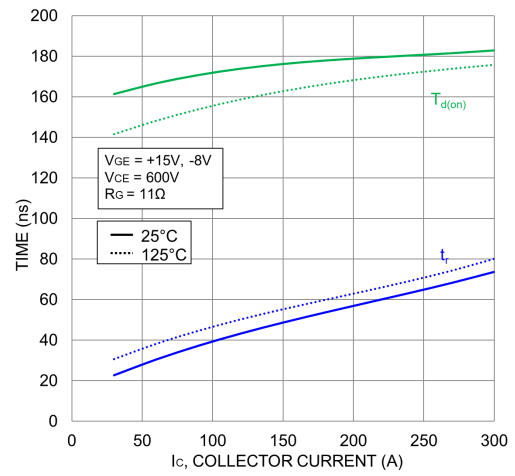


Figure 24. Typical Turn-On Switching Time vs.  $I_c$

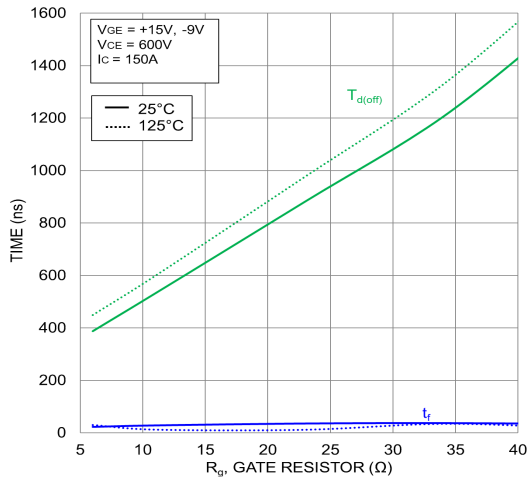


Figure 21. Typical Turn-Off Switching Time vs.  $R_g$

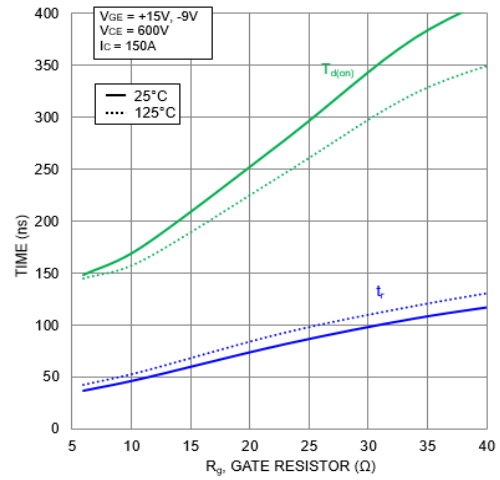


Figure 22. Typical Turn-On Switching Time vs.  $R_g$

TYPICAL SWITCHING CHARACTERISTICS – NEUTRAL POINT DIODE

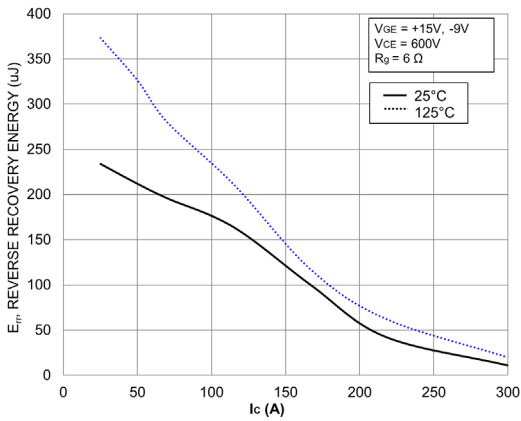


Figure 25. Typical Reverse Recovery Energy Loss vs.  $I_c$

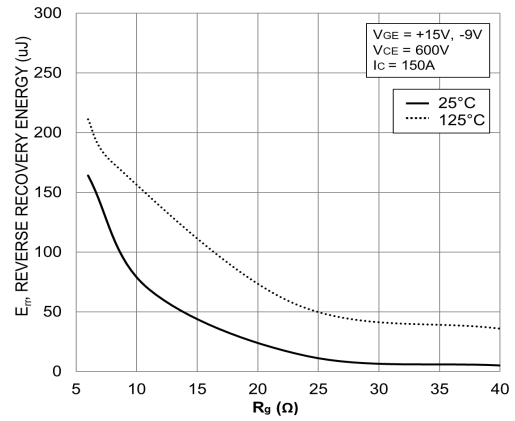


Figure 26. Typical Reverse Recovery Energy Loss vs.  $R_g$

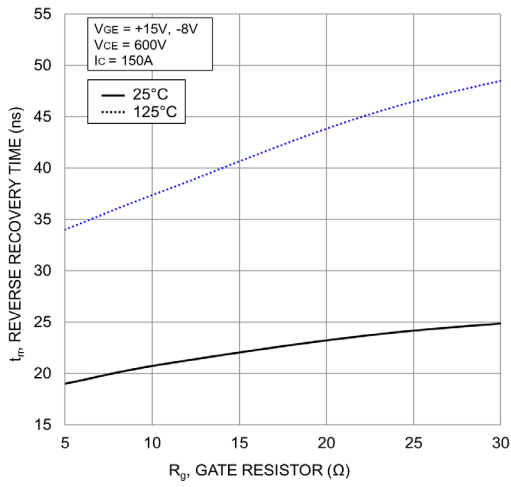


Figure 27. Typical Reverse Recovery Time vs.  $R_g$

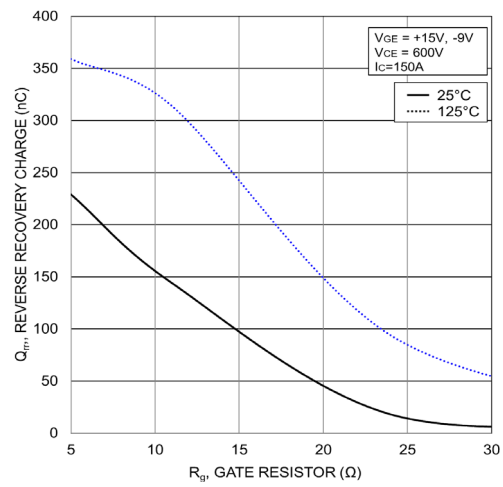


Figure 28. Typical Reverse Recovery Charge vs.  $R_g$

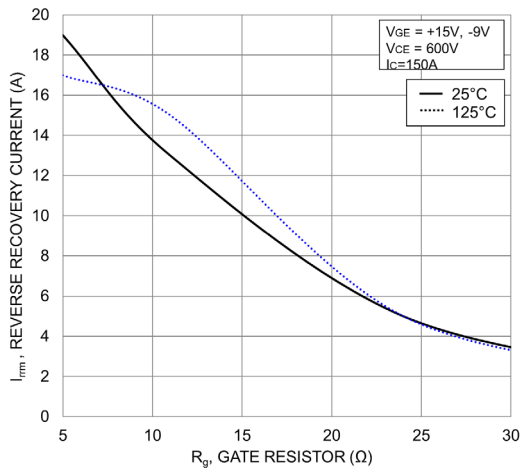


Figure 29. Typical Reverse Recovery Peak Current vs.  $R_g$

TYPICAL CHARACTERISTICS – INVERSE DIODE

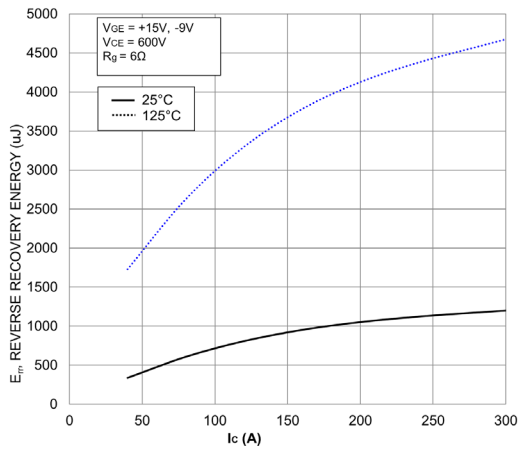


Figure 30. Typical Reverse Recovery Energy Loss vs.  $I_C$

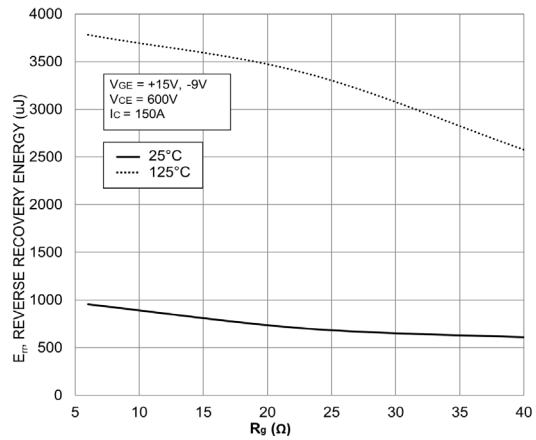


Figure 31. Typical Reverse Recovery Energy Loss vs.  $R_g$

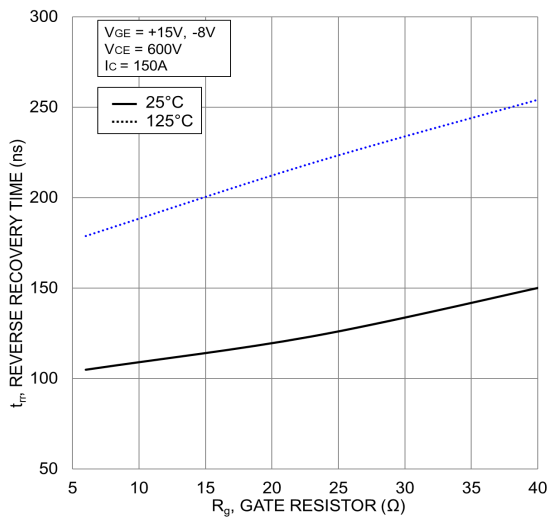


Figure 32. Typical Reverse Recovery Time vs.  $R_g$

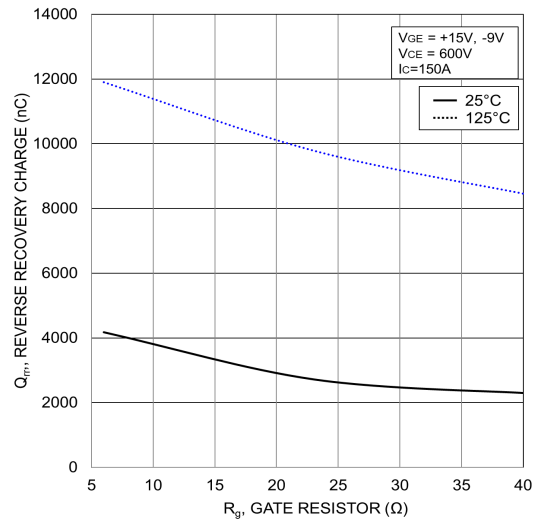


Figure 33. Typical Reverse Recovery Charge vs.  $R_g$

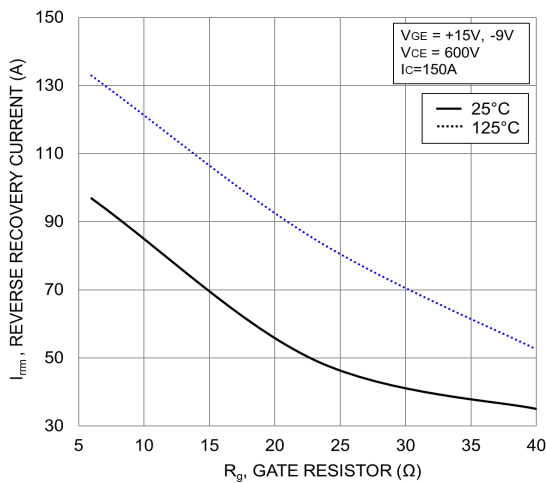


Figure 34. Typical Reverse Recovery Peak Current vs.  $R_g$

TYPICAL CHARACTERISTICS – IGBT, INVERSE DIODE AND NEUTRAL POINT DIODE

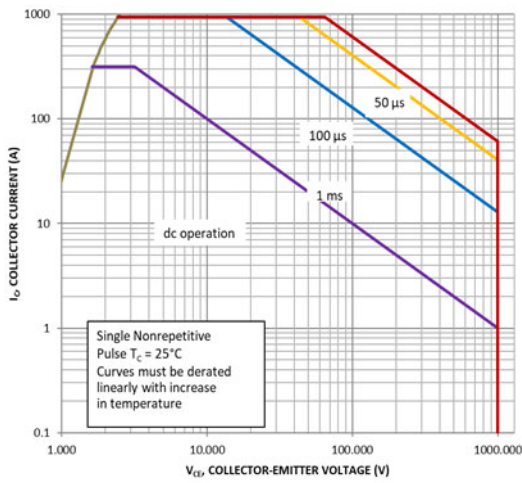


Figure 35. FBSOA – Outer IGBT

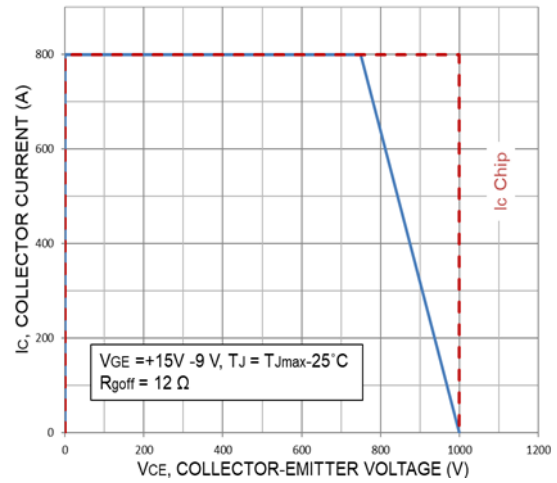


Figure 36. RBSOA – Outer IGBT

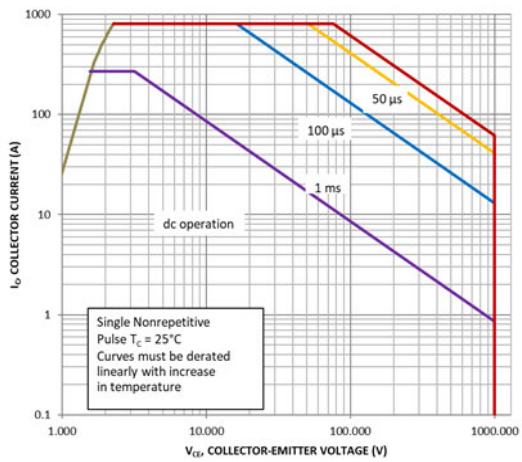


Figure 37. FBSOA – Inner IGBT

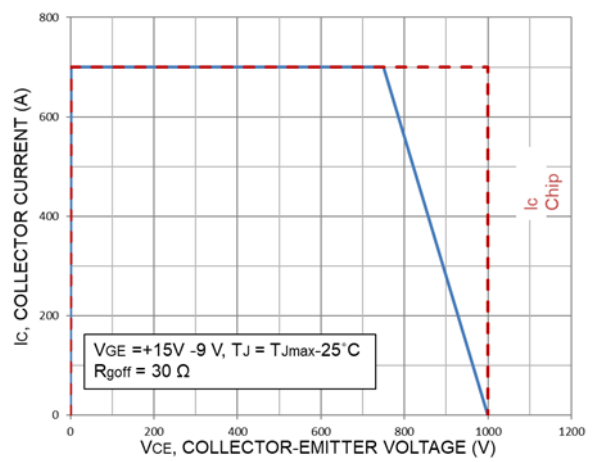


Figure 38. RBSOA – Inner IGBT

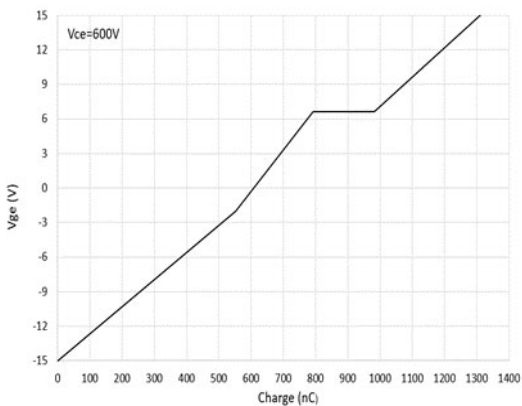


Figure 39. Gate Voltage vs. Gate Charge

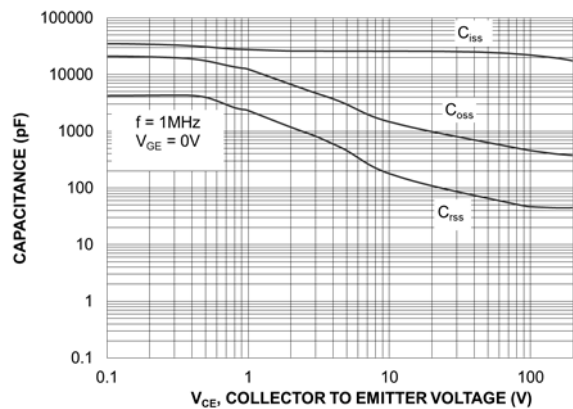


Figure 40. Capacitance Charge

TYPICAL CHARACTERISTICS – IGBT, INVERSE DIODE AND NEUTRAL POINT DIODE (CONTINUED)

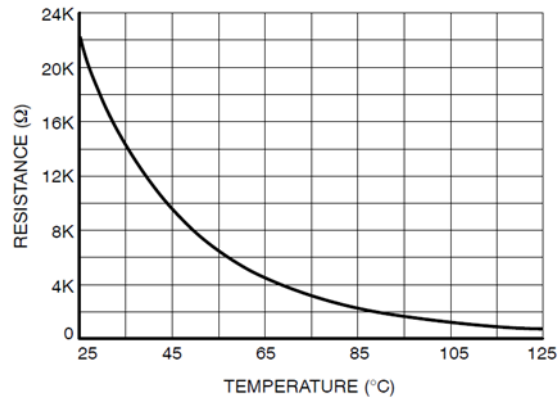


Figure 41. Thermistor Characteristics

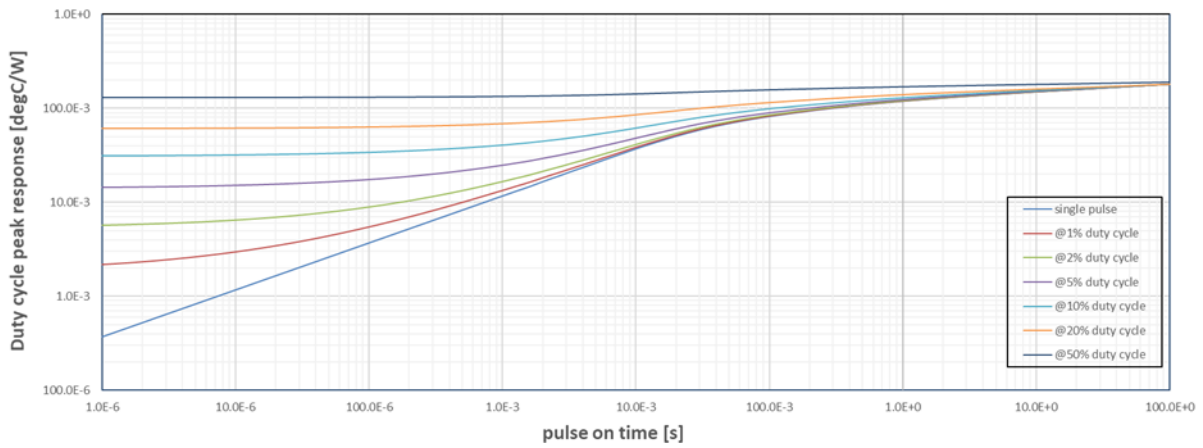


Figure 42. Transient Thermal Impedance – Outer IGBT

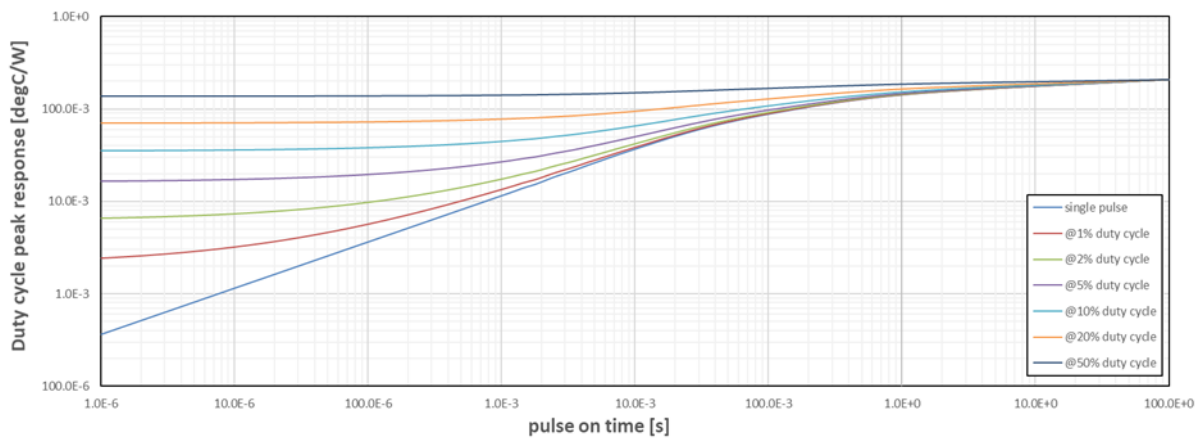


Figure 43. Transient Thermal Impedance – Inner IGBT

TYPICAL CHARACTERISTICS – IGBT, INVERSE DIODE AND NEUTRAL POINT DIODE (CONTINUED)

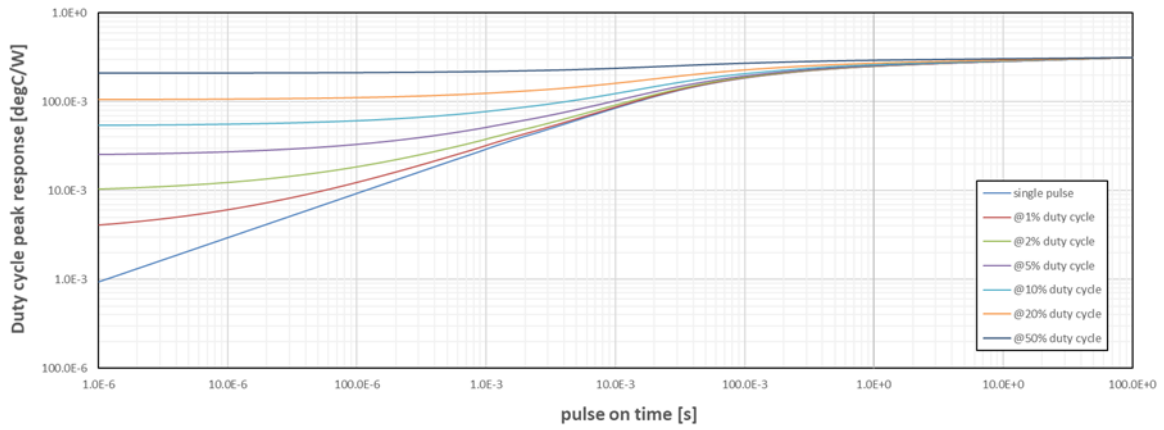


Figure 44. Transient Thermal Impedance – Inverse Diode

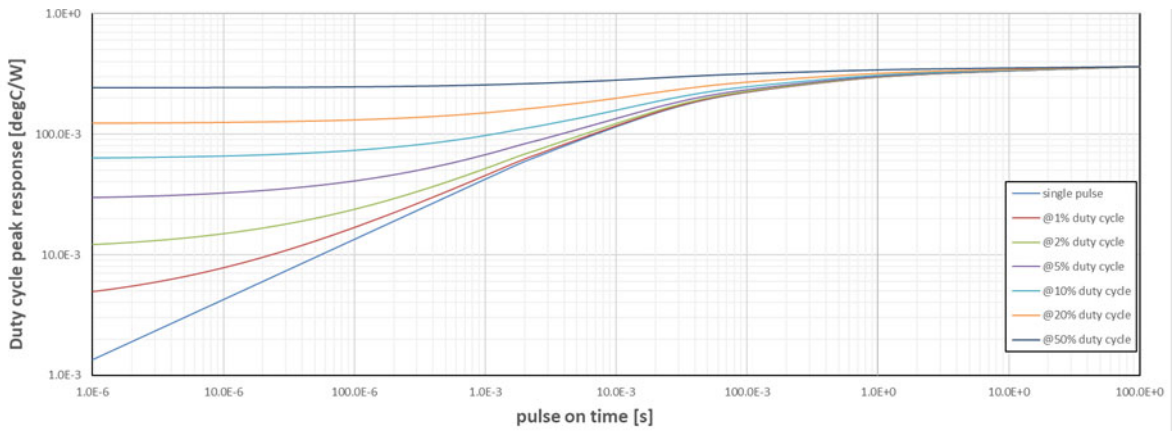


Figure 45. Transient Thermal Impedance – Neutral Point Diode

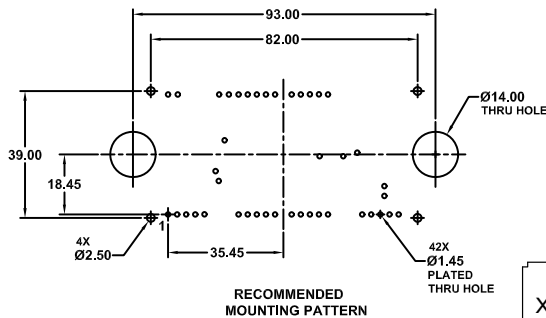
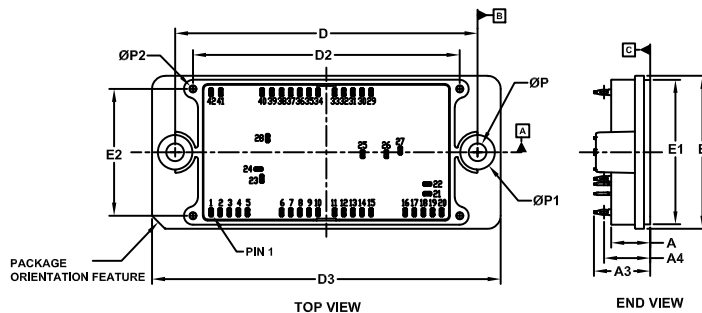
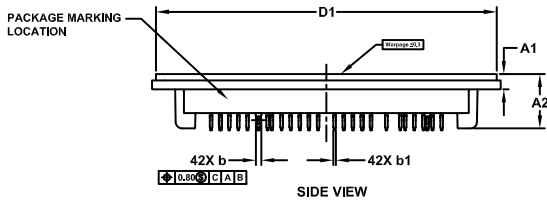
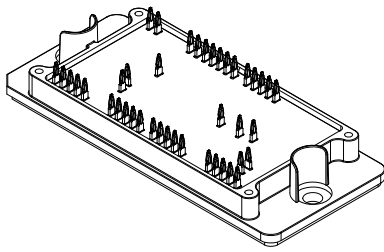


# MECHANICAL CASE OUTLINE PACKAGE DIMENSIONS



PIM42, 93.00x47.00x12.00  
CASE 180BH  
ISSUE A

DATE 11 OCT 2023



NOTES:

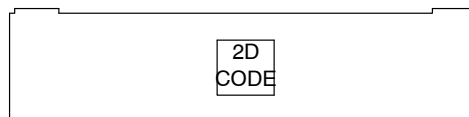
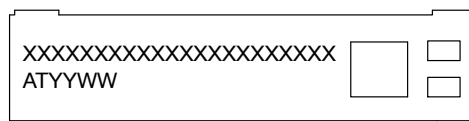
1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009.
2. CONTROLLING DIMENSION: MILLIMETERS
3. DIMENSIONS b AND b1 APPLY TO THE PLATED TERMINALS AND ARE MEASURED AT DIMENSION A4.
4. POSITION OF THE CENTER OF THE TERMINALS IS DETERMINED FROM DATUM B THE CENTER OF DIMENSION D, X DIRECTION, AND FROM DATUM A, Y DIRECTION. POSITIONAL TOLERANCE, AS NOTED IN DRAWING, APPLIES TO EACH TERMINAL IN BOTH DIRECTIONS.
5. PACKAGE MARKING IS LOCATED AS SHOWN ON THE SIDE OPPOSITE THE PACKAGE ORIENTATION FEATURES.
6. PRESS FIT PIN

DIM	MILLIMETERS		
	MIN.	NOM.	MAX.
A	11.70	12.00	12.30
A1	4.40	4.70	5.00
A2	16.40	16.70	17.00
A3	16.90	17.30	17.70
A4	13.97	14.18	14.39
b	1.61	1.66	1.71
b1	0.75	0.80	0.85
D	92.90	93.00	93.10
D1	104.45	104.75	105.05
D2	81.80	82.00	82.20
D3	106.90	107.20	107.50
E	46.20	47.00	47.80
E1	44.10	44.40	44.70
E2	38.80	39.00	39.10
P	5.40	5.50	5.60
P1	10.60	10.70	10.80
P2	1.80	2.00	2.20

NOTE 4

PIN	PIN POSITION		PIN	PIN POSITION	
	X	Y		X	Y
1	0.00	0.00	22	66.50	8.70
2	2.80	0.00	23	15.60	10.30
3	5.60	0.00	24	14.60	13.30
4	8.40	0.00	25	46.60	17.90
5	11.20	0.00	26	53.90	17.90
6	21.70	0.00	27	58.20	19.00
7	24.50	0.00	28	17.40	22.80
8	27.30	0.00	29	49.20	36.90
9	30.10	0.00	30	46.40	36.90
10	32.90	0.00	31	43.60	36.90
11	38.00	0.00	32	40.80	36.90
12	40.80	0.00	33	38.00	36.90
13	43.60	0.00	34	32.90	36.90
14	46.40	0.00	35	30.10	36.90
15	49.20	0.00	36	27.30	36.90
16	59.70	0.00	37	24.50	36.90
17	62.50	0.00	38	21.70	36.90
18	65.30	0.00	39	18.70	36.90
19	68.10	0.00	40	15.70	36.90
20	70.90	0.00	41	3.00	36.90
21	66.50	5.70	42	0.00	36.90

GENERIC MARKING DIAGRAM\*



XXXXX = Specific Device Code  
AT = Assembly & Test Site Code  
YYWW = Year and Work Week Code

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "µ", may or may not be present. Some products may not follow the Generic Marking.

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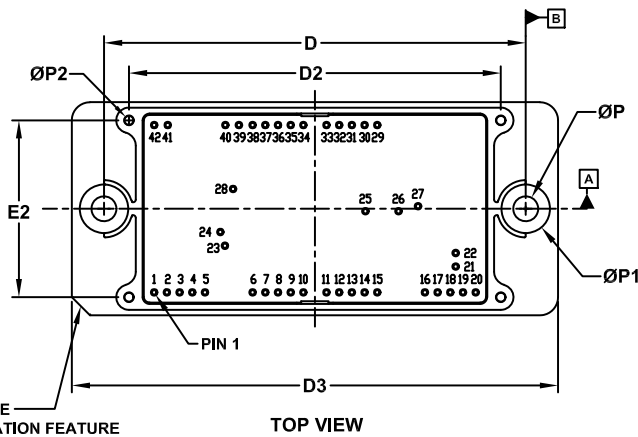
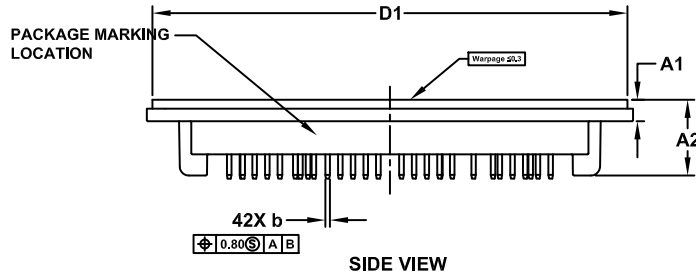
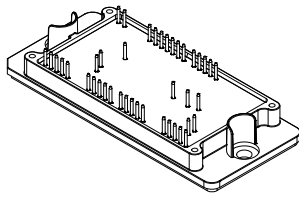
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# MECHANICAL CASE OUTLINE PACKAGE DIMENSIONS



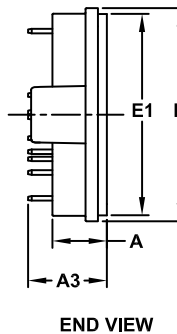
PIM42, 93.00x47.00x12.00  
CASE 180BS  
ISSUE A

DATE 12 OCT 2023



NOTES:

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009.
- CONTROLLING DIMENSION: MILLIMETERS
- DIMENSIONS b AND b1 APPLY TO THE PLATED TERMINALS AND ARE MEASURED AT DIMENSION A4.
- POSITION OF THE CENTER OF THE TERMINALS IS DETERMINED FROM DATUM B THE CENTER OF DIMENSION D, X DIRECTION, AND FROM DATUM A, Y DIRECTION. POSITIONAL TOLERANCE, AS NOTED IN DRAWING, APPLIES TO EACH TERMINAL IN BOTH DIRECTIONS.
- PACKAGE MARKING IS LOCATED AS SHOWN ON THE SIDE OPPOSITE THE PACKAGE ORIENTATION FEATURES.
- SOLDER PIN

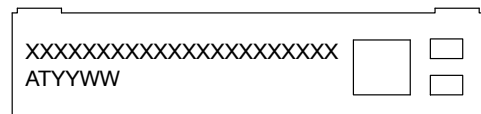


DIM	MILLIMETERS		
	MIN.	NOM.	MAX.
A	11.70	12.00	12.30
A1	4.40	4.70	5.00
A2	16.40	16.70	17.00
A3	16.80	17.20	17.60
b	0.95	1.00	1.05
D	92.90	93.00	93.10
D1	104.45	104.75	105.05
D2	81.80	82.00	82.20
D3	106.90	107.20	107.50
E	46.20	47.00	47.80
E1	44.10	44.40	44.70
E2	38.80	39.00	39.10
P	5.40	5.50	5.60
P1	10.60	10.70	10.80
P2	1.80	2.00	2.20

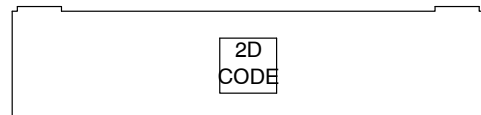
NOTE 4

PIN	PIN POSITION		PIN	PIN POSITION	
	X	Y		X	Y
1	0.00	0.00	22	66.50	8.70
2	2.80	0.00	23	15.60	10.30
3	5.60	0.00	24	14.60	13.30
4	8.40	0.00	25	46.60	17.90
5	11.20	0.00	26	53.90	17.90
6	21.70	0.00	27	58.20	19.00
7	24.50	0.00	28	17.40	22.80
8	27.30	0.00	29	49.20	36.90
9	30.10	0.00	30	46.40	36.90
10	32.90	0.00	31	43.60	36.90
11	38.00	0.00	32	40.80	36.90
12	40.80	0.00	33	38.00	36.90
13	43.60	0.00	34	32.90	36.90
14	46.40	0.00	35	30.10	36.90
15	49.20	0.00	36	27.30	36.90
16	59.70	0.00	37	24.50	36.90
17	62.50	0.00	38	21.70	36.90
18	65.30	0.00	39	18.70	36.90
19	68.10	0.00	40	15.70	36.90
20	70.90	0.00	41	3.00	36.90
21	66.50	5.70	42	0.00	36.90

GENERIC MARKING DIAGRAM\*



FRONTSIDE MARKING



BACKSIDE MARKING

XXXXX = Specific Device Code  
AT = Assembly & Test Site Code  
YYWW = Year and Work Week Code

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "C" or microdot "▪", may or may not be present. Some products may not follow the Generic Marking.

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